

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10574956	TIETSCHERT, HANKA
	Examiner	Art Unit
	BLAINE G NEWAY	4133

SEARCHED

Class	Subclass	Date	Examiner
206	521.1- 521.9	2/14/08	Blaine Neway
220	508	2/14/08	Blaine Neway

SEARCH NOTES

Search Notes	Date	Examiner
Consulted with Primary Examiner Luan Bul	2/6/08	Blaine Neway

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner